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| Search Notes | | | | Application No. | Applicant(s) |
| | | | | 10/073,571 | DAHNEKE ET AL. |
| | | | | Examiner | Art Unit |
| | | | | Alan S Chen | 2182 |

| SEARCHED | | | |
|----------|----------|-----------|----------|
| Class | Subclass | Date | Examiner |
| 710 | 8 | 3/17/2005 | ASC |
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| updated | 6/17/05 | ASC | |
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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | |
|---|-----------|------|
| | DATE | EXMR |
| (EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT PLUS | 3/17/2005 | ASC |
| updated | 6/17/05 | ASC |
| updated inventor's search and PLUS | 11/2/05 | ASC |
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| INTERFERENCE SEARCHED | | | |
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